

This Page Is Inserted by IFW Operations
and is not a part of the Official Record

BEST AVAILABLE IMAGES

Defective images within this document are accurate representations of the original documents submitted by the applicant.

Defects in the images may include (but are not limited to):

- BLACK BORDERS
- TEXT CUT OFF AT TOP, BOTTOM OR SIDES
- FADED TEXT
- ILLEGIBLE TEXT
- SKEWED/SLANTED IMAGES
- COLORED PHOTOS
- BLACK OR VERY BLACK AND WHITE DARK PHOTOS
- GRAY SCALE DOCUMENTS

IMAGES ARE BEST AVAILABLE COPY.

**As rescanning documents *will not* correct images,
please do not report the images to the
Image Problem Mailbox.**

Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims:

Claim 1 (Original) A method for continuously preparing a silicon oxide powder, comprising the steps of:

feeding a raw material powder mixture containing silicon dioxide powder into a reaction furnace,

heating the mixture in the furnace in an inert gas or in vacuum to a temperature of 1,100 to 1,600°C to produce a silicon oxide gas,

introducing the silicon oxide gas into a cooling chamber through a transfer conduit which is maintained at a temperature of from higher than 1,000°C to 1,300°C, thereby causing silicon oxide to deposit on a surface of a substrate which is disposed and cooled in the cooling chamber, and

continuously recovering the silicon oxide deposit.

Claim 2 (Original) The method of claim 1 wherein the raw material powder mixture is a mixture comprised of a silicon dioxide powder and a metal silicon powder.

Claim 3 (Cancelled)

Claim 4 (New) The method of claim 1 wherein the raw material powder mixture is a mixture comprised of a silicon dioxide powder and a reducing powder therefor.

Claim 5 (New) The method of claim 1 wherein the raw material powder mixture is a mixture comprised of a silicon dioxide powder and a carbon-containing powder.

Claim 6 (New) A method according to claim 1, wherein heating the mixture in the furnace is to a temperature of 1,200 to 1,500°C.

Claim 7 (New) A method according to claim 1, wherein when heating the mixture in the furnace, the furnace is under vacuum

Claim 8 (New) A method according to claim 1, wherein the transfer conduit is maintained at 1,100 to 1,200°C.

Claim 9 (New) A method according to claim 1, wherein the substrate is cooled to 200 to 500°C.

Claim 10 (New) A method according to claim 1, wherein the substrate is cooled to 300 to 400°C.

Claim 11 (New) A method according to claim 1, wherein recovering the silicon oxide deposit is performed by a scraper.